

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10578960	MINIXHOFER, RAINER
Examiner	Art Unit	
ROBERT HUBER	2892	

SEARCHED

Class	Subclass	Date	Examiner
257	432	3/5/08	Robert Huber
257	438, 461, 431, 464, 414	3/4/08	Robert Huber
257	440	8/7/08	RH
257	E31.032, E31.038	10/22/09	RH
438	69, 70, 74	10/22/09	RH

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search - EAST (USOCR, USPAT, USPGPUB) - See Printout	3/4/08	Robert Huber
PLUS Search - Kewords: optoelectronic, zone, plate, semiconductor, silicon, oxide, nitride, detection, region, visible, light, diffraction, diffractive, fresnel, transistion, interface, dopant, radiation, metal	3/4/08	Robert Huber
EAST Search (USOCR, USPAT, USPGPUB, FPRS, EPO, JPO, DERWENT, IBM) - See Printout	3/4/08 - 3/5/08	Robert Huber
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	8/7/08	RH
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	1/7/08	RH
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	10/22/09	RH
.clm. search - EAST (USPAT, USPGPUB, USOCR, USPAD) - see printout	10/22/09	RH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
257	438, 440, 464, 431, 432, 461, E31.032, E31.038	10/22/09	RH
438	69, 70, 74	10/22/09	RH